


Search Notes 	Application/Control No. 10559497	Applicant(s)/Patent Under Reexamination FUJII, TAKEHIRO
	Examiner MORGAN VARNER	Art Unit 2895

SEARCHED			
Class	Subclass	Date	Examiner
438		24 March 2009	Morgan Varner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search of USPAT, USGPUB, EPO, JPO, IBMTDB	23 March 2009	Morgan Varner
Consulted Primary Patent examiner W. M. BrewsterE	23 March 2009	Morgan Varner
Consulted Supervisory Patent Examiner N. Drew Richards	24 March 2009	Morgan Varner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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